

High CMR, High Speed TTL Compatible Optocouplers

Technical Data

6N137

HCNW137	HCPL-0631
HCNW2601	HCPL-0661
HCNW2611	HCPL-2601
HCPL-0600	HCPL-2611
HCPL-0601	HCPL-2630
HCPL-0611	HCPL-2631
HCPL-0630	HCPL-4661

Features

- 5 kV/ μ s Minimum Common Mode Rejection (CMR) at $V_{CM} = 50$ V for HCPL-X601/X631, HCNW2601 and 10 kV/ μ s Minimum CMR at $V_{CM} = 1000$ V for HCPL-X611/X661, HCNW2611
- High Speed: 10 MBd Typical
- LSTTL/TTL Compatible
- Low Input Current Capability: 5 mA
- Guaranteed ac and dc Performance over Temperature: -40°C to +85°C
- Available in 8-Pin DIP, SOIC-8, Widebody Packages
- Storable Output (Single Channel Products Only)
- Safety Approval
 - UL Recognized - 3750 V rms for 1 minute and 5000 V rms* for 1 minute per UL1577
 - CSA Approved
 - IEC/EN/DIN EN 60747-5-2
 - Approved with $V_{IORM} = 630$ V peak for HCPL-2611 Option 060 and $V_{IORM} = 1414$ V peak for HCNW137/26X1
- MIL-PRF-38534 Hermetic Version Available (HCPL-56XX/66XX)

Applications

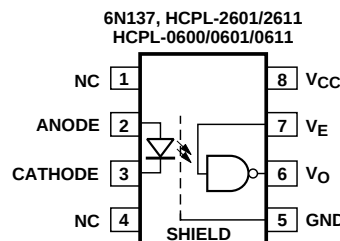
- Isolated Line Receiver
- Computer-Peripheral Interfaces
- Microprocessor System Interfaces
- Digital Isolation for A/D, D/A Conversion
- Switching Power Supply
- Instrument Input/Output Isolation
- Ground Loop Elimination
- Pulse Transformer Replacement

- Power Transistor Isolation in Motor Drives
- Isolation of High Speed Logic Systems

Description

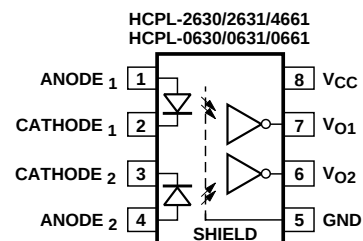
The 6N137, HCPL-26XX/06XX/4661, HCNW137/26X1 are optically coupled gates that combine a GaAsP light emitting diode and an integrated high gain photo detector. An enable input allows the detector to be strobed. The output of the detector IC is

Functional Diagram



TRUTH TABLE
(POSITIVE LOGIC)

LED	ENABLE	OUTPUT
ON	H	L
OFF	H	H
ON	L	H
OFF	L	H
ON	NC	L
OFF	NC	H



TRUTH TABLE
(POSITIVE LOGIC)

LED	OUTPUT
ON	L
OFF	H

*5000 V rms/1 Minute rating is for HCNW137/26X1 and Option 020 (6N137, HCPL-2601/11/30/31, HCPL-4661) products only.

A 0.1 μ F bypass capacitor must be connected between pins 5 and 8.

CAUTION: It is advised that normal static precautions be taken in handling and assembly of this component to prevent damage and/or degradation which may be induced by ESD.

an open collector Schottky-clamped transistor. The internal shield provides a guaranteed common mode transient immunity specification of 5,000 V/ μ s for the HCPL-X601/X631 and HCNW2601, and 10,000 V/ μ s for the HCPL-X611/X661 and HCNW2611.

This unique design provides maximum ac and dc circuit isolation while achieving TTL compatibility. The optocoupler ac and dc operational parameters are guaranteed from -40°C to +85°C allowing troublefree system performance.

The 6N137, HCPL-26XX, HCPL-06XX, HCPL-4661, HCNW137, and HCNW26X1 are suitable for high speed logic interfacing, input/output buffering, as line receivers in environments that conventional line receivers cannot tolerate and are recommended for use in extremely high ground or induced noise environments.

Selection Guide

Minimum CMR		Input On-Current (mA)	Output Enable	8-Pin DIP (300 Mil)		Small-Outline SO-8		Widebody (400 Mil)	Hermetic
dV/dt (V/ μ s)	V _{CM} (V)			Single Channel Package	Dual Channel Package	Single Channel Package	Dual Channel Package	Single Channel Package	Single and Dual Channel Packages
NA	NA	5	YES	6N137		HCPL-0600		HCNW137	
			NO		HCPL-2630		HCPL-0630		
5,000	50		YES	HCPL-2601		HCPL-0601		HCNW2601	
			NO		HCPL-2631		HCPL-0631		
10,000	1,000		YES	HCPL-2611		HCPL-0611		HCNW2611	
			NO		HCPL-4661		HCPL-0661		
1,000	50	3	YES	HCPL-2602 ^[1]					
3, 500	300		YES	HCPL-2612 ^[1]					
1,000	50		YES	HCPL-261A ^[1]		HCPL-061A ^[1]			
			NO		HCPL-263A ^[1]		HCPL-063A ^[1]		
1,000 ^[2]	1,000		YES	HCPL-261N ^[1]		HCPL-061N ^[1]			
			NO		HCPL-263N ^[1]		HCPL-063N ^[1]		
1,000	50	12.5	^[3]						HCPL-193X ^[1] HCPL-56XX ^[1] HCPL-66XX ^[1]

Notes:

1. Technical data are on separate Agilent publications.
2. 15 kV/ μ s with V_{CM} = 1 kV can be achieved using Agilent application circuit.
3. Enable is available for single channel products only, except for HCPL-193X devices.

Ordering Information

Specify Part Number followed by Option Number (if desired).

Example:

HCPL-2611#XXXX

- 020 = 5000 V rms/1 minute UL Rating Option*
- 060 = IEC/EN/DIN EN 60747-5-2 $V_{IORM} = 630$ Vpeak Option**
- 300 = Gull Wing Surface Mount Option†
- 500 = Tape and Reel Packaging Option
- XXXE = Lead Free Option

Option data sheets available. Contact Agilent sales representative or authorized distributor for information.

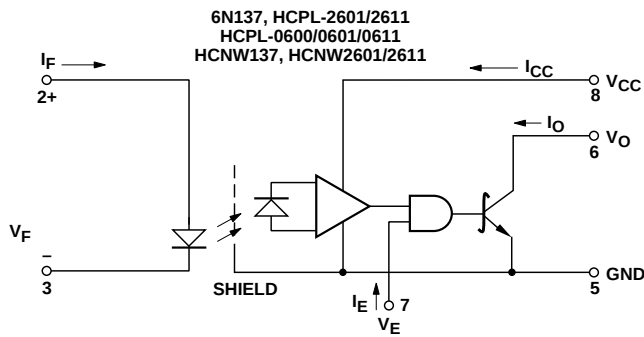
Remarks: The notation “#” is used for existing products, while (new) products launched since 15th July 2001 and lead free option will use “-”

*For 6N137, HCPL-2601/11/30/31 and HCPL-4661 (8-pin DIP products) only.

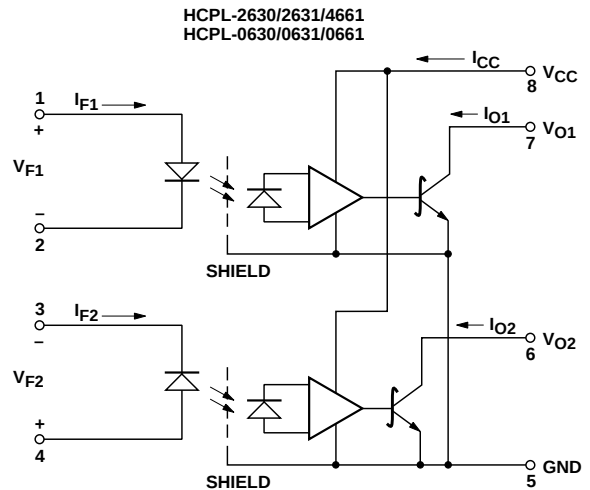
**For HCPL-2611 only. Combination of Option 020 and Option 060 is not available.

†Gull wing surface mount option applies to through hole parts only.

Schematic

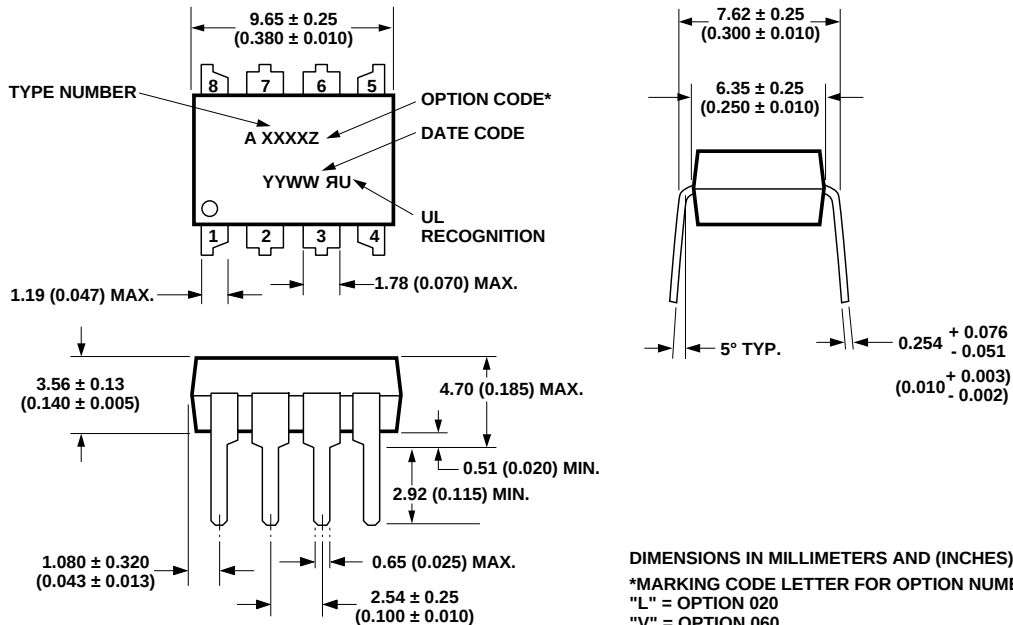


USE OF A 0.1 μ F BYPASS CAPACITOR CONNECTED BETWEEN PINS 5 AND 8 IS RECOMMENDED (SEE NOTE 5).



Package Outline Drawings

8-pin DIP Package** (6N137, HCPL-2601/11/30/31, HCPL-4661)



DIMENSIONS IN MILLIMETERS AND (INCHES).

*MARKING CODE LETTER FOR OPTION NUMBERS

"L" = OPTION 020

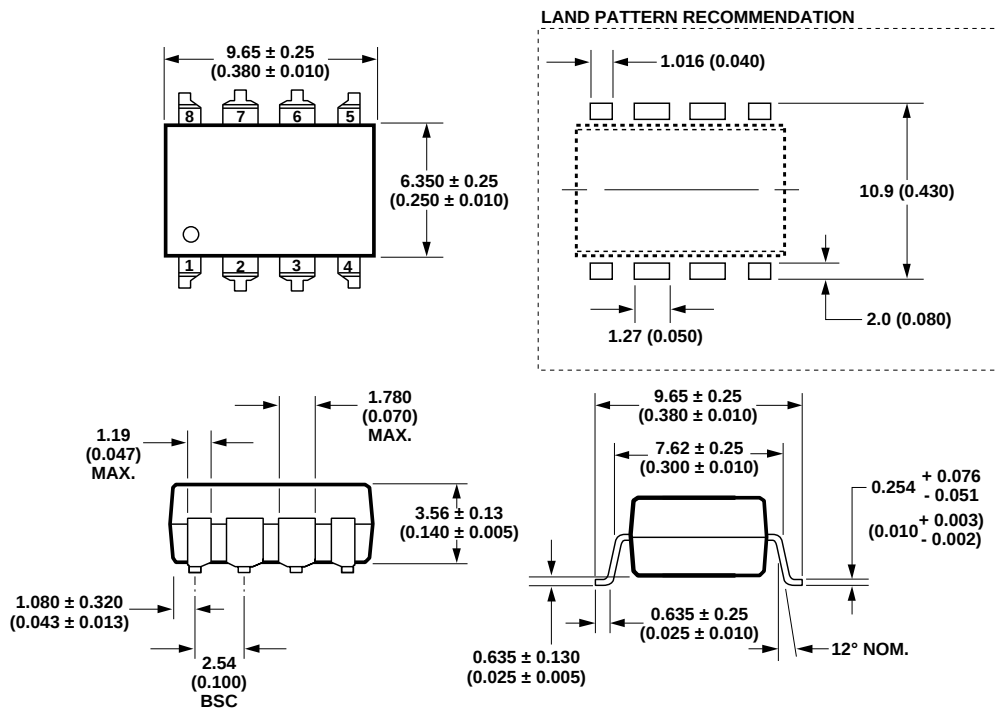
"V" = OPTION 060

OPTION NUMBERS 300 AND 500 NOT MARKED.

**JEDEC Registered Data (for 6N137 only).

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

8-pin DIP Package with Gull Wing Surface Mount Option 300 (6N137, HCPL-2601/11/30/31, HCPL-4661)

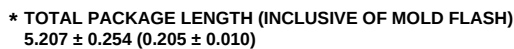


DIMENSIONS IN MILLIMETERS (INCHES).

LEAD COPLANARITY = 0.10 mm (0.004 INCHES).

NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

Small-Outline SO-8 Package (HCPL-0600/01/11/30/31/61)



DIMENSIONS IN MILLIMETERS (INCHES).

LEAD COPLANARITY = 0.10 mm (0.004 INCHES) MAX.

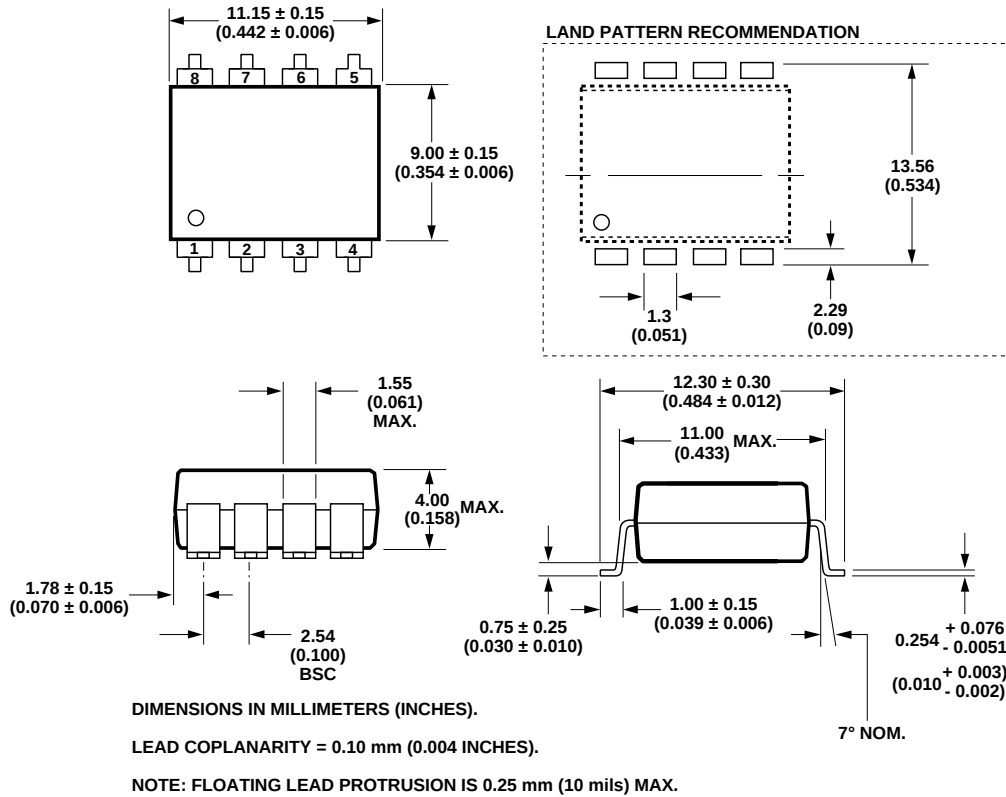
NOTE: FLOATING LEAD PROTRUSION IS 0.15 mm (6 mils) MAX.

8-Pin Widebody DIP Package (HCNW137, HCNW2601/11)

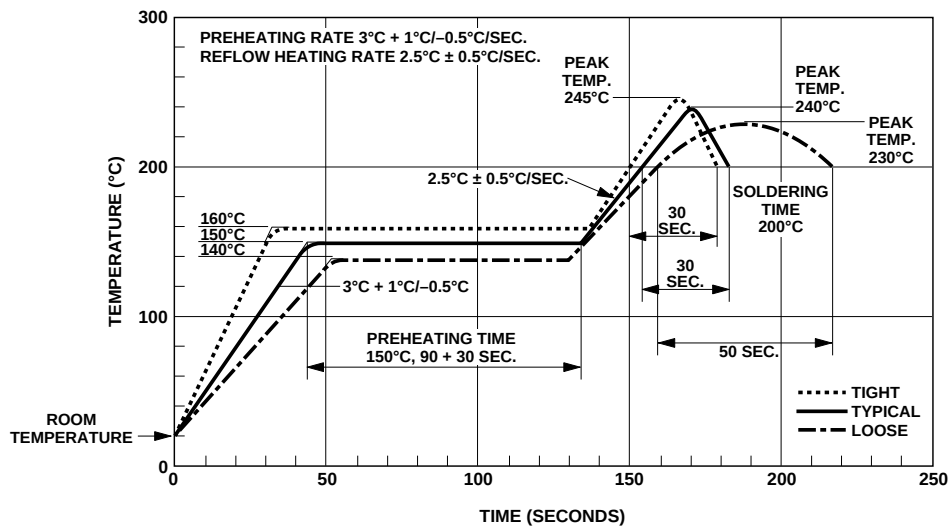


NOTE: FLOATING LEAD PROTRUSION IS 0.25 mm (10 mils) MAX.

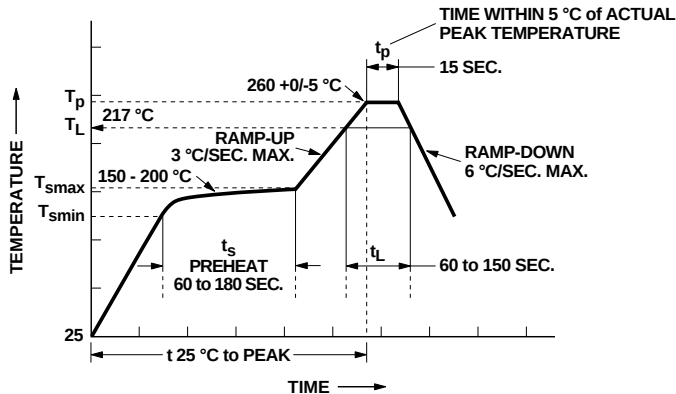
8-Pin Widebody DIP Package with Gull Wing Surface Mount Option 300 (HCNW137, HCNW2601/11)



Solder Reflow Temperature Profile



Pb-free IR Profile



NOTES:
 THE TIME FROM 25 °C to PEAK TEMPERATURE = 8 MINUTES MAX.
 $T_{smmax} = 200\text{ °C}$, $T_{smmin} = 150\text{ °C}$

Regulatory Information

The 6N137, HCPL-26XX/06XX/46XX, and HCNW137/26XX have been approved by the following organizations:

UL

Recognized under UL 1577, Component Recognition Program, File E55361.

CSA

Approved under CSA Component Acceptance Notice #5, File CA 88324.

IEC/EN/DIN EN 60747-5-2

Approved under
 IEC 60747-5-2:1997 + A1:2002
 EN 60747-5-2:2001 + A1:2002
 DIN EN 60747-5-2 (VDE 0884
 Teil 2):2003-01
 (Option 060 and HCNW only)

Insulation and Safety Related Specifications

Parameter	Symbol	8-pin DIP (300 Mil) Value	SO-8 Value	Widebody (400 Mil) Value	Units	Conditions
Minimum External Air Gap (External Clearance)	L(101)	7.1	4.9	9.6	mm	Measured from input terminals to output terminals, shortest distance through air.
Minimum External Tracking (External Creepage)	L(102)	7.4	4.8	10.0	mm	Measured from input terminals to output terminals, shortest distance path along body.
Minimum Internal Plastic Gap (Internal Clearance)		0.08	0.08	1.0	mm	Through insulation distance, conductor to conductor, usually the direct distance between the photoemitter and photodetector inside the optocoupler cavity.
Minimum Internal Tracking (Internal Creepage)		NA	NA	4.0	mm	Measured from input terminals to output terminals, along internal cavity.
Tracking Resistance (Comparative Tracking Index)	CTI	200	200	200	Volts	DIN IEC 112/VDE 0303 Part 1
Isolation Group		IIIa	IIIa	IIIa		Material Group (DIN VDE 0110, 1/89, Table 1)

Option 300 - surface mount classification is Class A in accordance with CECC 00802.

IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics (HCPL-2611 Option 060 Only)

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage ≤ 300 V rms for rated mains voltage ≤ 450 V rms		I-IV	
		I-III	
Climatic Classification		55/85/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	630	V_{peak}
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	1181	V_{peak}
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	945	V_{peak}
Highest Allowable Overvoltage* (Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	6000	V_{peak}
Safety Limiting Values (Maximum values allowed in the event of a failure, also see Figure 16, Thermal Derating curve.)			
Case Temperature	T_S	175	$^{\circ}C$
Input Current	$I_{S,INPUT}$	230	mA
Output Power	$P_{S,OUTPUT}$	600	mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	R_S	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, IEC/EN/DIN EN 60747-5-2, for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

IEC/EN/DIN EN 60747-5-2 Insulation Related Characteristics(HCNW137/2601/2611 Only)

Description	Symbol	Characteristic	Units
Installation classification per DIN VDE 0110/1.89, Table 1 for rated mains voltage ≤ 600 V rms for rated mains voltage ≤ 1000 V rms		I-IV	
		I-III	
Climatic Classification (DIN IEC 68 part 1)		55/100/21	
Pollution Degree (DIN VDE 0110/1.89)		2	
Maximum Working Insulation Voltage	V_{IORM}	1414	V_{peak}
Input to Output Test Voltage, Method b* $V_{IORM} \times 1.875 = V_{PR}$, 100% Production Test with $t_m = 1$ sec, Partial Discharge < 5 pC	V_{PR}	2651	V_{peak}
Input to Output Test Voltage, Method a* $V_{IORM} \times 1.5 = V_{PR}$, Type and sample test, $t_m = 60$ sec, Partial Discharge < 5 pC	V_{PR}	2121	V_{peak}
Highest Allowable Overvoltage* (Transient Overvoltage, $t_{ini} = 10$ sec)	V_{IOTM}	8000	V_{peak}
Safety Limiting Values (Maximum values allowed in the event of a failure, also see Figure 16, Thermal Derating curve.)			
Case Temperature	T_S	150	$^{\circ}C$
Input Current	$I_{S,INPUT}$	400	mA
Output Power	$P_{S,OUTPUT}$	700	mW
Insulation Resistance at T_S , $V_{IO} = 500$ V	R_S	$\geq 10^9$	Ω

*Refer to the front of the optocoupler section of the current catalog, under Product Safety Regulations section, IEC/EN/DIN EN 60747-5-2, for a detailed description.

Note: Isolation characteristics are guaranteed only within the safety maximum ratings which must be ensured by protective circuits in application.

Absolute Maximum Ratings* (No Derating Required up to 85°C)

Parameter	Symbol	Package**	Min.	Max.	Units	Note
Storage Temperature	T _S		-55	125	°C	
Operating Temperature†	T _A		-40	85	°C	
Average Forward Input Current	I _F	Single 8-Pin DIP Single SO-8 Widebody		20	mA	2
		Dual 8-Pin DIP Dual SO-8		15		1, 3
Reverse Input Voltage	V _R	8-Pin DIP, SO-8		5	V	1
		Widebody		3		
Input Power Dissipation	P _I	Widebody		40	mW	
Supply Voltage (1 Minute Maximum)	V _{CC}			7	V	
Enable Input Voltage (Not to Exceed V _{CC} by more than 500 mV)	V _E	Single 8-Pin DIP Single SO-8 Widebody		V _{CC} + 0.5	V	
Enable Input Current	I _E			5	mA	
Output Collector Current	I _O			50	mA	1
Output Collector Voltage	V _O			7	V	1
Output Collector Power Dissipation	P _O	Single 8-Pin DIP Single SO-8 Widebody		85	mW	1, 4
		Dual 8-Pin DIP Dual SO-8		60		
Lead Solder Temperature (Through Hole Parts Only)	T _{LS}	8-Pin DIP	260°C for 10 sec., 1.6 mm below seating plane			
		Widebody	260°C for 10 sec., up to seating plane			
Solder Reflow Temperature Profile (Surface Mount Parts Only)		SO-8 and Option 300	See Package Outline Drawings section			

*JEDEC Registered Data (for 6N137 only).

Ratings apply to all devices except otherwise noted in the **Package column.

†0°C to 70°C on JEDEC Registration.

Recommended Operating Conditions

Parameter	Symbol	Min.	Max.	Units
Input Current, Low Level	I _{FL} *	0	250	μA
Input Current, High Level ^[1]	I _{FH} **	5	15	mA
Power Supply Voltage	V _{CC}	4.5	5.5	V
Low Level Enable Voltage†	V _{EL}	0	0.8	V
High Level Enable Voltage†	V _{EH}	2.0	V _{CC}	V
Operating Temperature	T _A	-40	85	°C
Fan Out (at R _L = 1 kΩ) ^[1]	N		5	TTL Loads
Output Pull-up Resistor	R _L	330	4 k	Ω

*The off condition can also be guaranteed by ensuring that V_{FL} ≤ 0.8 volts.

**The initial switching threshold is 5 mA or less. It is recommended that 6.3 mA to 10 mA be used for best performance and to permit at least a 20% LED degradation guardband.

†For single channel products only.

Electrical Specifications

Over recommended temperature ($T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$) unless otherwise specified. All Typical at $V_{CC} = 5\text{ V}$, $T_A = 25^{\circ}\text{C}$. All enable test conditions apply to single channel products only. See note 5.

Parameter	Sym.	Package	Min.	Typ.	Max.	Units	Test Conditions		Fig.	Note
High Level Output Current	I _{OH} *	All		5.5	100	μA	V _{CC} = 5.5 V, V _E = 2.0 V, V _O = 5.5 V, I _F = 250 μA		1	1, 6, 19
Input Threshold Current	I _{TH}	Single Channel Widebody		2.0	5.0	mA	V _{CC} = 5.5 V, V _E = 2.0 V, V _O = 0.6 V, I _{OL} (Sinking) = 13 mA		2, 3	19
		Dual Channel		2.5						
Low Level Output Voltage	V _{OL} *	8-Pin DIP SO-8		0.35	0.6	V	V _{CC} = 5.5 V, V _E = 2.0 V, I _F = 5 mA, I _{OL} (Sinking) = 13 mA		2, 3, 4, 5	1, 19
		Widebody		0.4						
High Level Supply Current	I _{CCH}	Single Channel		7.0	10.0*	mA	V _E = 0.5 V	V _{CC} = 5.5 V I _F = 0 mA		7
				6.5			V _E = V _{CC}			
		Dual Channel		10	15		Both Channels			
Low Level Supply Current	I _{CCL}	Single Channel		9.0	13.0*	mA	V _E = 0.5 V	V _{CC} = 5.5 V I _F = 10 mA		8
				8.5			V _E = V _{CC}			
		Dual Channel		13	21		Both Channels			
High Level Enable Current	I _{EH}	Single Channel		-0.7	-1.6	mA	V _{CC} = 5.5 V, V _E = 2.0 V			
Low Level Enable Current	I _{EL} *			-0.9	-1.6	mA	V _{CC} = 5.5 V, V _E = 0.5 V			9
High Level Enable Voltage	V _{EH}		2.0			V				19
Low Level Enable Voltage	V _{EL}				0.8	V				
Input Forward Voltage	V _F	8-Pin DIP SO-8	1.4	1.5	1.75*	V	T _A = 25°C	I _F = 10 mA	6, 7	1
			1.3		1.80					
		Widebody	1.25	1.64	1.85		T _A = 25°C			
			1.2		2.05					
Input Reverse Breakdown Voltage	BV _R *	8-Pin DIP SO-8	5			V	I _R = 10 μA			1
		Widebody	3				I _R = 100 μA, T _A = 25°C			
Input Diode Temperature Coefficient	ΔV _F /ΔT _A	8-Pin DIP SO-8		-1.6		mV/°C	I _F = 10 mA		7	1
		Widebody		-1.9						
Input Capacitance	C _{IN}	8-Pin DIP SO-8		60		pF	f = 1 MHz, V _F = 0 V			1
		Widebody		70						

*JEDEC registered data for the 6N137. The JEDEC Registration specifies 0°C to $+70^{\circ}\text{C}$. HP specifies -40°C to $+85^{\circ}\text{C}$.

Switching Specifications (AC)

Over Recommended Temperature ($T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$), $V_{CC} = 5\text{ V}$, $I_F = 7.5\text{ mA}$ unless otherwise specified.
All Typicals at $T_A = 25^\circ\text{C}$, $V_{CC} = 5\text{ V}$.

Parameter	Sym.	Package**	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Propagation Delay Time to High Output Level	t_{PLH}		20	48	75*	ns	$T_A = 25^\circ\text{C}$ $R_L = 350\ \Omega$ $C_L = 15\text{ pF}$	8, 9, 10	1, 10, 19
Propagation Delay Time to Low Output Level	t_{PHL}		25	50	75*	ns	$T_A = 25^\circ\text{C}$		1, 11, 19
Pulse Width Distortion	$ t_{PHL} - t_{PLH} $	8-Pin DIP SO-8		3.5	35	ns		8, 9, 10, 11	13, 19
		Widebody			40				
Propagation Delay Skew	t_{PSK}				40	ns			12, 13, 19
Output Rise Time (10-90%)	t_r			24		ns		12	1, 19
Output Fall Time (90-10%)	t_f			10		ns		12	1, 19
Propagation Delay Time of Enable from V_{EH} to V_{EL}	t_{ELH}	Single Channel		30		ns	$R_L = 350\ \Omega$, $C_L = 15\text{ pF}$, $V_{EL} = 0\text{ V}$, $V_{EH} = 3\text{ V}$	13, 14	14
Propagation Delay Time of Enable from V_{EL} to V_{EH}	t_{EHL}	Single Channel		20		ns			15

*JEDEC registered data for the 6N137.

Ratings apply to all devices except otherwise noted in the **Package column.

Parameter	Sym.	Device	Min.	Typ.	Units	Test Conditions	Fig.	Note
Logic High Common Mode Transient Immunity	$ CM_H $	6N137 HCPL-2630 HCPL-0600/0630 HCNW137		10,000	V/ μs	$ V_{CM} = 10\text{ V}$ $V_{CC} = 5\text{ V}$, $I_F = 0\text{ mA}$, $V_{O(MIN)} = 2\text{ V}$, $R_L = 350\ \Omega$, $T_A = 25^\circ\text{C}$	15	1, 16, 18, 19
		HCPL-2601/2631 HCPL-0601/0631 HCNW2601	5,000	10,000		$ V_{CM} = 50\text{ V}$		
		HCPL-2611/4661 HCPL-0611/0661 HCNW2611	10,000	15,000		$ V_{CM} = 1\text{ kV}$		
Logic Low Common Mode Transient Immunity	$ CM_L $	6N137 HCPL-2630 HCPL-0600/0630 HCNW137		10,000	V/ μs	$ V_{CM} = 10\text{ V}$ $V_{CC} = 5\text{ V}$, $I_F = 7.5\text{ mA}$, $V_{O(MAX)} = 0.8\text{ V}$, $R_L = 350\ \Omega$, $T_A = 25^\circ\text{C}$	15	1, 17, 18, 19
		HCPL-2601/2631 HCPL-0601/0631 HCNW2601	5,000	10,000		$ V_{CM} = 50\text{ V}$		
		HCPL-2611/4661 HCPL-0611/0661 HCNW2611	10,000	15,000		$ V_{CM} = 1\text{ kV}$		

Package Characteristics

All Typical at $T_A = 25^\circ\text{C}$.

Parameter	Sym.	Package	Min.	Typ.	Max.	Units	Test Conditions	Fig.	Note
Input-Output Insulation	I_{L-O}^*	Single 8-Pin DIP Single SO-8			1	μA	45% RH, $t = 5\text{ s}$, $V_{L-O} = 3\text{ kV dc}$, $T_A = 25^\circ\text{C}$		20, 21
Input-Output Momentary Withstand Voltage**	V_{ISO}	8-Pin DIP, SO-8	3750			V rms	RH $\leq 50\%$, $t = 1\text{ min}$, $T_A = 25^\circ\text{C}$		20, 21
		Widebody	5000						20, 22
		OPT 020†	5000						
Input-Output Resistance	R_{L-O}	8-Pin DIP, SO-8		10^{12}		Ω	$V_{L-O} = 500\text{ V dc}$ $T_A = 25^\circ\text{C}$ $T_A = 100^\circ\text{C}$		1, 20, 23
		Widebody	10^{12}	10^{13}					
			10^{11}						
Input-Output Capacitance	C_{L-O}	8-Pin DIP, SO-8		0.6		pF	$f = 1\text{ MHz}$, $T_A = 25^\circ\text{C}$		1, 20, 23
		Widebody		0.5	0.6				
Input-Input Insulation Leakage Current	I_{I-I}	Dual Channel		0.005		μA	RH $\leq 45\%$, $t = 5\text{ s}$, $V_{I-I} = 500\text{ V}$		24
Resistance (Input-Input)	R_{I-I}	Dual Channel		10^{11}		Ω			24
Capacitance (Input-Input)	C_{I-I}	Dual 8-Pin DIP		0.03		pF	$f = 1\text{ MHz}$		24
		Dual SO-8		0.25					

*JEDEC registered data for the 6N137. The JEDEC Registration specifies 0°C to 70°C . Agilent specifies -40°C to 85°C .

**The Input-Output Momentary Withstand Voltage is a dielectric voltage rating that should not be interpreted as an input-output continuous voltage rating. For the continuous voltage rating refer to the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table (if applicable), your equipment level safety specification or Agilent Application Note 1074 entitled "Optocoupler Input-Output Endurance Voltage."

†For 6N137, HCPL-2601/2611/2630/2631/4661 only.

Notes:

- Each channel.
- Peaking circuits may produce transient input currents up to 50 mA, 50 ns maximum pulse width, provided average current does not exceed 20 mA.
- Peaking circuits may produce transient input currents up to 50 mA, 50 ns maximum pulse width, provided average current does not exceed 15 mA.
- Derate linearly above 80°C free-air temperature at a rate of $2.7\text{ mW}/^\circ\text{C}$ for the SOIC-8 package.
- Bypassing of the power supply line is required, with a $0.1\text{ }\mu\text{F}$ ceramic disc capacitor adjacent to each optocoupler as illustrated in Figure 17. Total lead length between both ends of the capacitor and the isolator pins should not exceed 20 mm.
- The JEDEC registration for the 6N137 specifies a maximum I_{OH} of 250 μA . Agilent guarantees a maximum I_{OH} of 100 μA .
- The JEDEC registration for the 6N137 specifies a maximum I_{CCH} of 15 mA. Agilent guarantees a maximum I_{CCH} of 10 mA.
- The JEDEC registration for the 6N137 specifies a maximum I_{CCL} of 18 mA. Agilent guarantees a maximum I_{CCL} of 13 mA.
- The JEDEC registration for the 6N137 specifies a maximum I_{EL} of -2.0 mA . Agilent guarantees a maximum I_{EL} of -1.6 mA .
- The t_{PLH} propagation delay is measured from the 3.75 mA point on the falling edge of the input pulse to the 1.5 V point on the rising edge of the output pulse.
- The t_{PHL} propagation delay is measured from the 3.75 mA point on the rising edge of the input pulse to the 1.5 V point on the falling edge of the output pulse.
- t_{PSK} is equal to the worst case difference in t_{PHL} and/or t_{PLH} that will be seen between units at any given temperature and specified test conditions.
- See application section titled "Propagation Delay, Pulse-Width Distortion and Propagation Delay Skew" for more information.
- The t_{ELH} enable propagation delay is measured from the 1.5 V point on the falling edge of the enable input pulse to the 1.5 V point on the rising edge of the output pulse.
- The t_{EHL} enable propagation delay is measured from the 1.5 V point on the rising edge of the enable input pulse to the 1.5 V point on the falling edge of the output pulse.
- CM_H is the maximum tolerable rate of rise of the common mode voltage to assure that the output will remain in a high logic state (i.e., $V_O > 2.0\text{ V}$).
- CM_L is the maximum tolerable rate of fall of the common mode voltage to assure that the output will remain in a low logic state (i.e., $V_O < 0.8\text{ V}$).
- For sinusoidal voltages, $(|dV_{CM}| / dt)_{\max} = \pi f_{CM} V_{CM}(p-p)$.

19. No external pull up is required for a high logic state on the enable input. If the V_E pin is not used, tying V_E to V_{CC} will result in improved CMR performance. For single channel products only.
20. Device considered a two-terminal device: pins 1, 2, 3, and 4 shorted together, and pins 5, 6, 7, and 8 shorted together.
21. In accordance with UL1577, each optocoupler is proof tested by applying an insulation test voltage ≥ 4500 V rms for one second (leakage detection current limit, $I_{L,O} \leq 5 \mu A$). This test is performed before the 100% production test for partial discharge (Method b) shown in the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table, if applicable.
22. In accordance with UL 1577, each optocoupler is proof tested by applying an insulation test voltage ≥ 6000 V rms for one second (leakage detection current limit, $I_{L,O} \leq 5 \mu A$). This test is performed before the 100% production test for partial discharge (Method b) shown in the IEC/EN/DIN EN 60747-5-2 Insulation Characteristics Table, if applicable.
23. Measured between the LED anode and cathode shorted together and pins 5 through 8 shorted together. For dual channel products only.
24. Measured between pins 1 and 2 shorted together, and pins 3 and 4 shorted together. For dual channel products only.

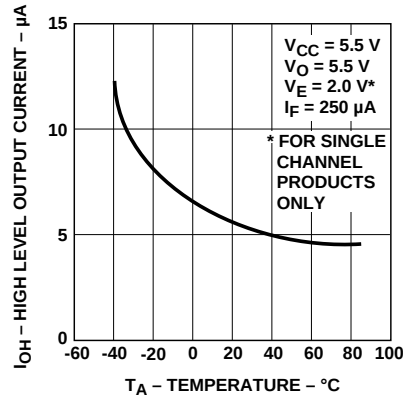


Figure 1. Typical High Level Output Current vs. Temperature.

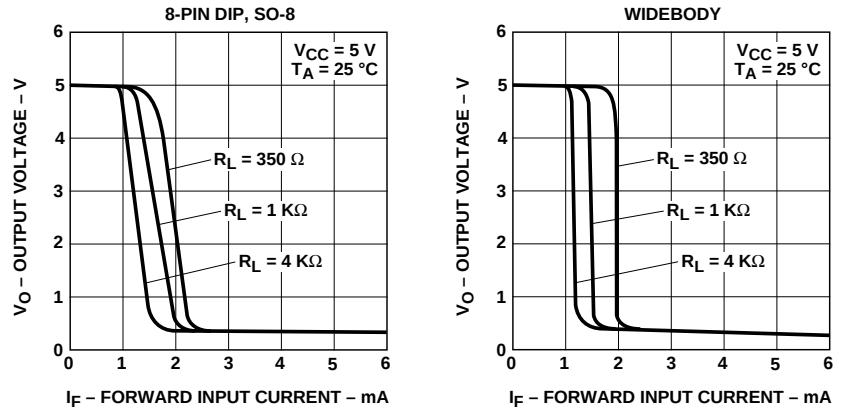


Figure 2. Typical Output Voltage vs. Forward Input Current.

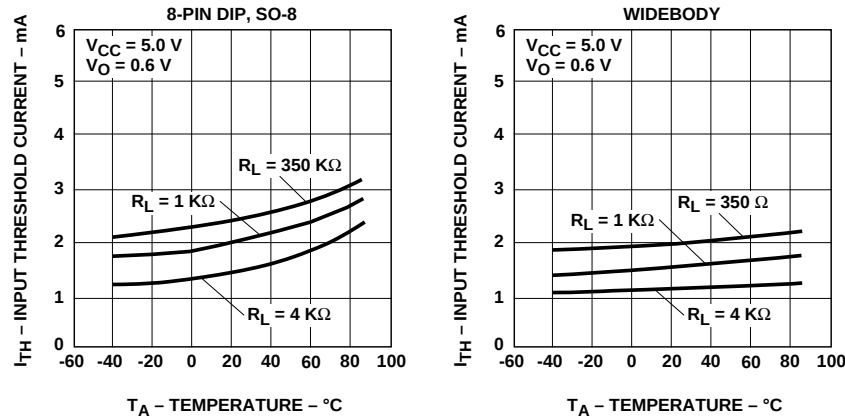


Figure 3. Typical Input Threshold Current vs. Temperature.

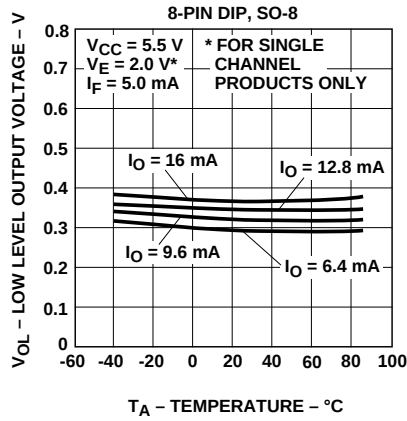


Figure 4. Typical Low Level Output Voltage vs. Temperature.

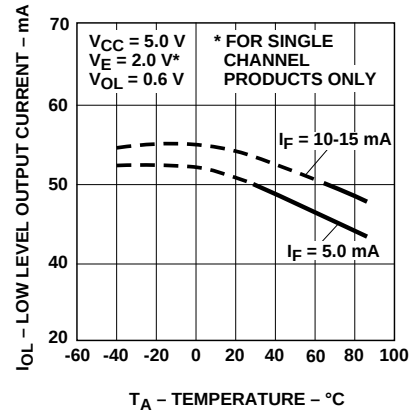
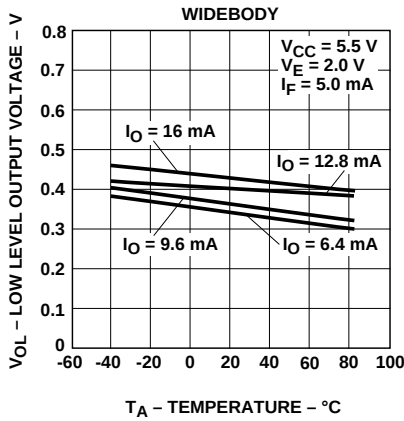


Figure 5. Typical Low Level Output Current vs. Temperature.

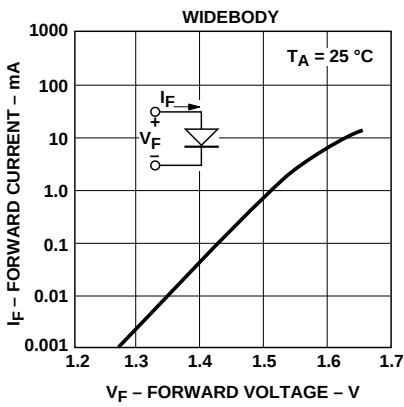
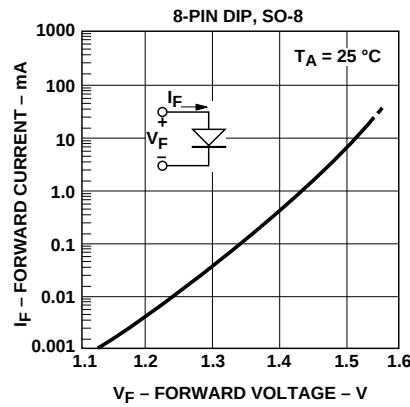


Figure 6. Typical Input Diode Forward Characteristic.

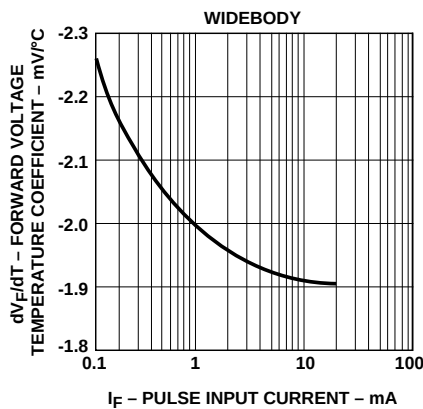
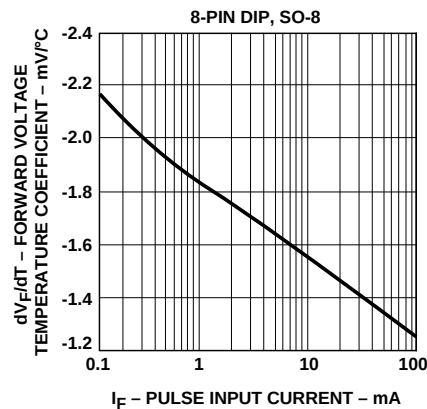
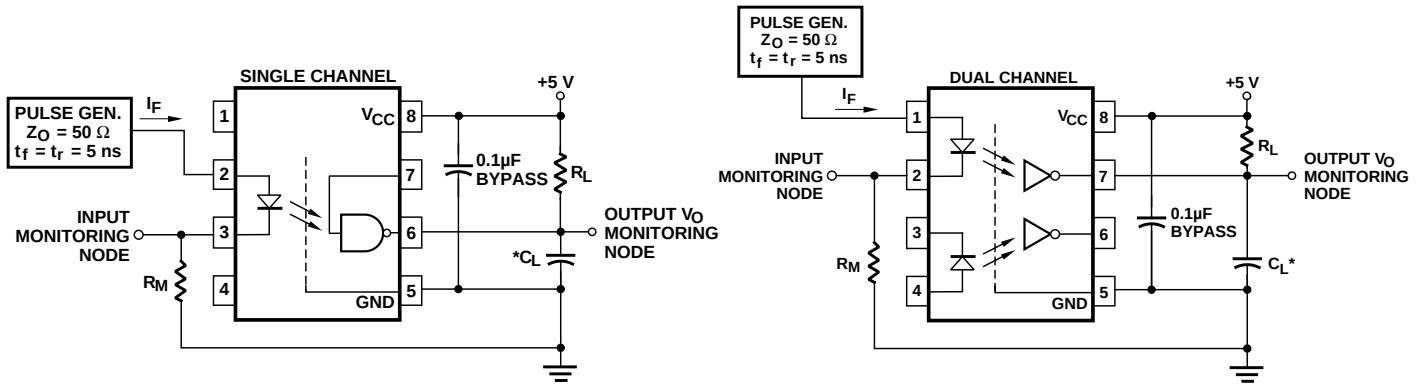


Figure 7. Typical Temperature Coefficient of Forward Voltage vs. Input Current.



* C_L IS APPROXIMATELY 15 pF WHICH INCLUDES PROBE AND STRAY WIRING CAPACITANCE.

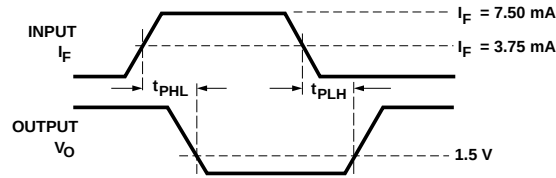


Figure 8. Test Circuit for t_{PHL} and t_{PLH} .

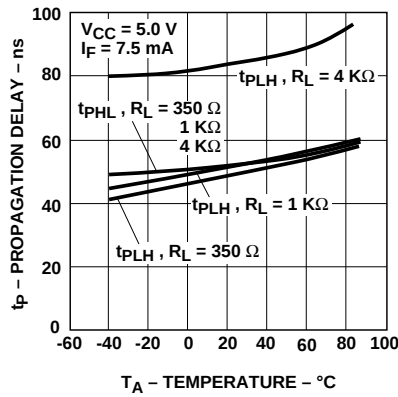


Figure 9. Typical Propagation Delay vs. Temperature.

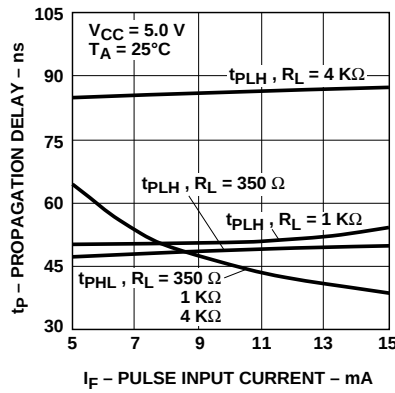


Figure 10. Typical Propagation Delay vs. Pulse Input Current.

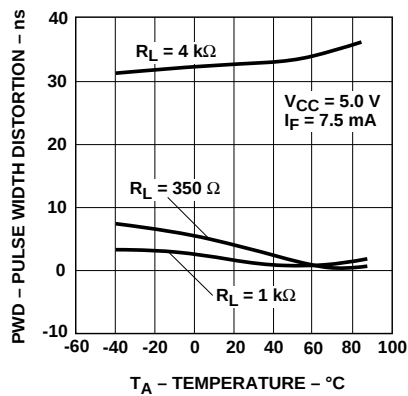


Figure 11. Typical Pulse Width Distortion vs. Temperature.

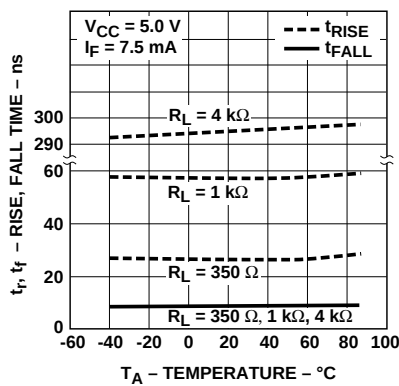


Figure 12. Typical Rise and Fall Time vs. Temperature.

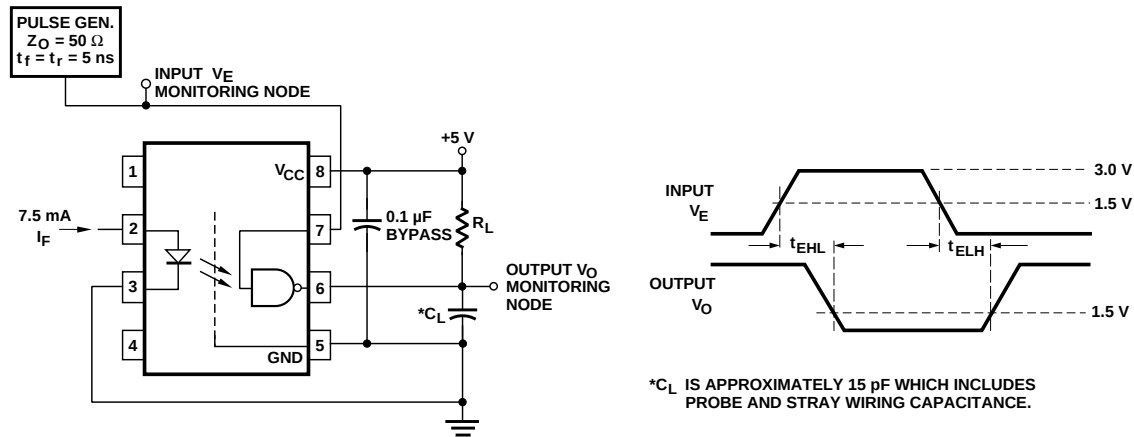


Figure 13. Test Circuit for t_{EHL} and t_{ELH} .

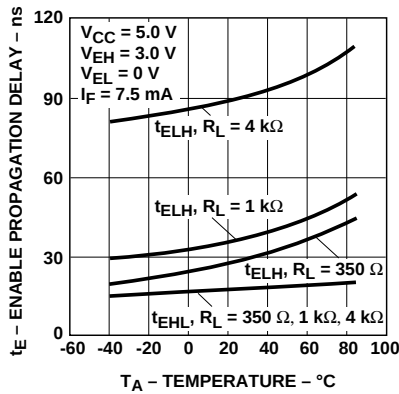


Figure 14. Typical Enable Propagation Delay vs. Temperature.

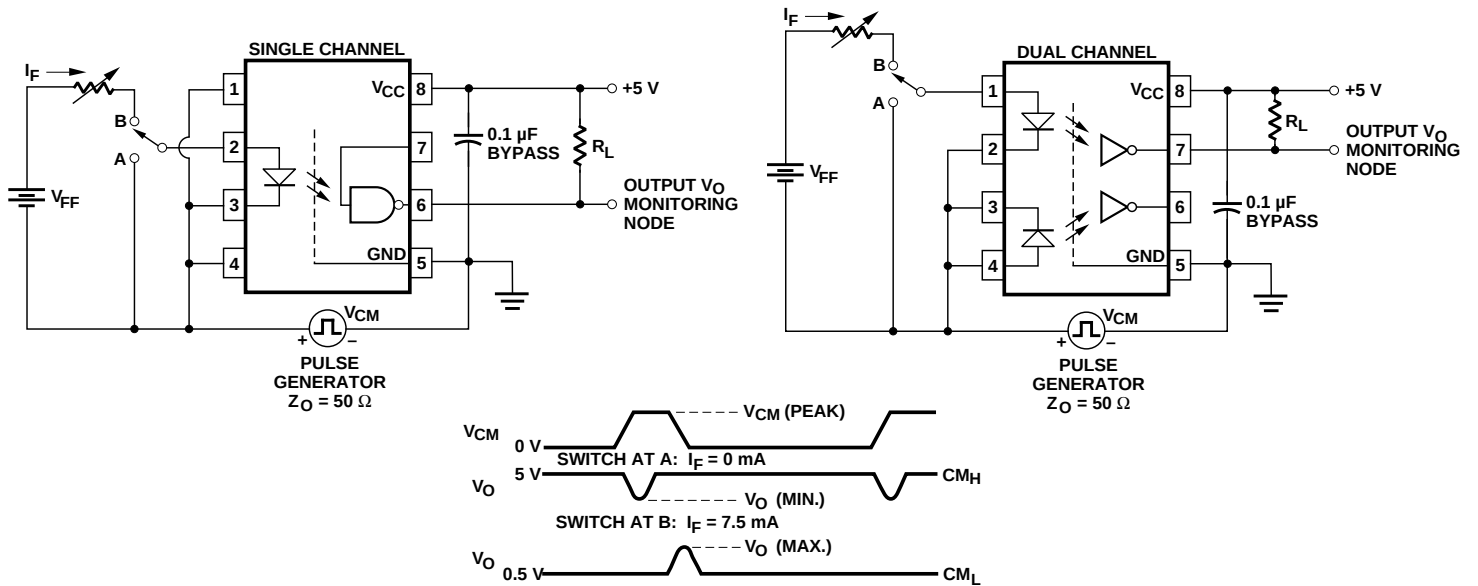


Figure 15. Test Circuit for Common Mode Transient Immunity and Typical Waveforms.

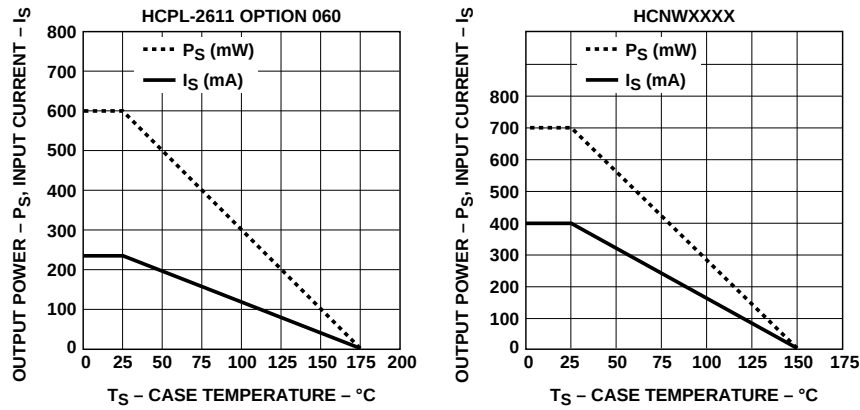


Figure 16. Thermal Derating Curve, Dependence of Safety Limiting Value with Case Temperature per IEC/EN/DIN EN 60747-5-2.

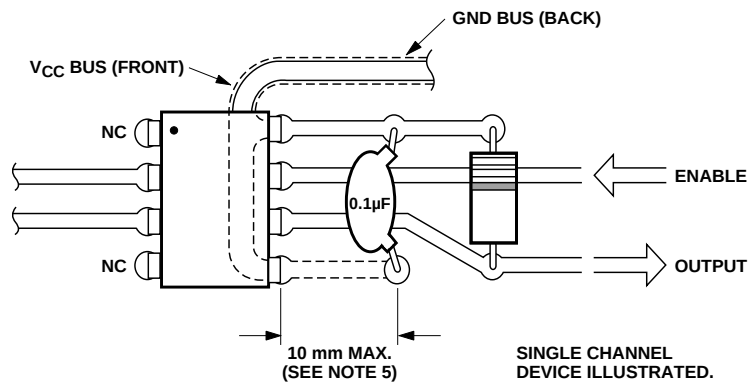
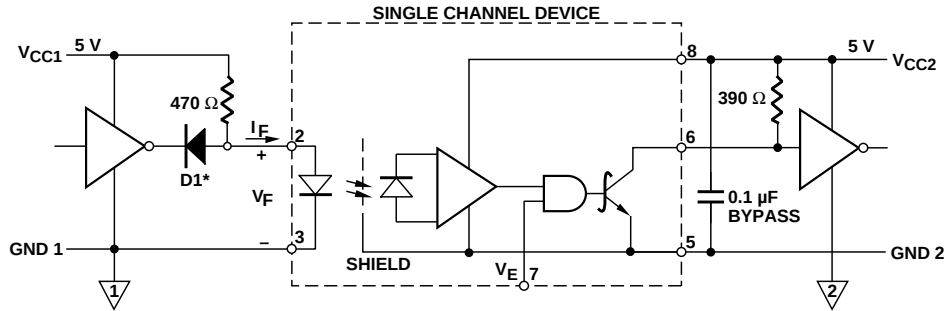


Figure 17. Recommended Printed Circuit Board Layout.



*DIODE D1 (1N916 OR EQUIVALENT) IS NOT REQUIRED FOR UNITS WITH OPEN COLLECTOR OUTPUT.

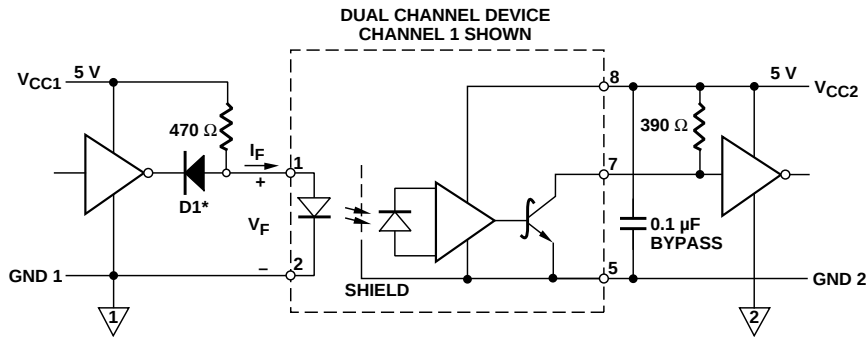


Figure 18. Recommended TTL/LSTTL to TTL/LSTTL Interface Circuit.

Propagation Delay, Pulse-Width Distortion and Propagation Delay Skew

Propagation delay is a figure of merit which describes how quickly a logic signal propagates through a system. The propagation delay from low to high (t_{PLH}) is the amount of time required for an input signal to propagate to the output, causing the output to change from low to high. Similarly, the propagation delay from high to low (t_{PHL}) is the amount of time required for the input signal to propagate to the output causing the output to change from high to low (see Figure 8).

Pulse-width distortion (PWD) results when t_{PLH} and t_{PHL} differ in value. PWD is defined as the difference between t_{PLH} and t_{PHL} and often determines the maximum data rate capability of a transmission system. PWD can be expressed in percent by dividing the PWD (in ns) by the minimum pulse width (in ns) being transmitted. Typically, PWD on the order of 20-30% of the minimum pulse width is tolerable; the exact figure depends on the particular application (RS232, RS422, T-1, etc.).

Propagation delay skew, t_{PSK} , is an important parameter to consider in parallel data applica-

tions where synchronization of signals on parallel data lines is a concern. If the parallel data is being sent through a group of optocouplers, differences in propagation delays will cause the data to arrive at the outputs of the optocouplers at different times. If this difference in propagation delays is large enough, it will determine the maximum rate at which parallel data can be sent through the optocouplers.

Propagation delay skew is defined as the difference between the minimum and maximum propagation delays, either t_{PLH} or t_{PHL} , for any given group of optocouplers which are operating under the same conditions (i.e., the same drive current, supply voltage, output load, and operating temperature). As illustrated in Figure 19, if the inputs of a group of optocouplers are switched either ON or OFF at the same time, t_{PSK} is the difference between the shortest propagation delay, either t_{PLH} or t_{PHL} , and the longest propagation delay, either t_{PLH} or t_{PHL} .

As mentioned earlier, t_{PSK} can determine the maximum parallel data transmission rate. Figure 20 is the timing diagram of a typical parallel data application with both the clock and the data lines being sent through optocouplers. The figure shows data and clock

signals at the inputs and outputs of the optocouplers. To obtain the maximum data transmission rate, both edges of the clock signal are being used to clock the data; if only one edge were used, the clock signal would need to be twice as fast.

Propagation delay skew represents the uncertainty of where an edge might be after being sent through an optocoupler. Figure 20 shows that there will be uncertainty in both the data and the clock lines. It is important that these two areas of uncertainty not overlap, otherwise the clock signal might arrive before all of the data outputs have settled, or some of the data outputs may start to change before the clock signal has arrived. From these considerations, the absolute minimum pulse width that can be sent through optocouplers in a parallel application is twice t_{PSK} . A cautious design should use a slightly longer pulse width to ensure that any additional uncertainty in the rest of the circuit does not cause a problem.

The t_{PSK} specified optocouplers offer the advantages of guaranteed specifications for propagation delays, pulsewidth distortion and propagation delay skew over the recommended temperature, input current, and power supply ranges.

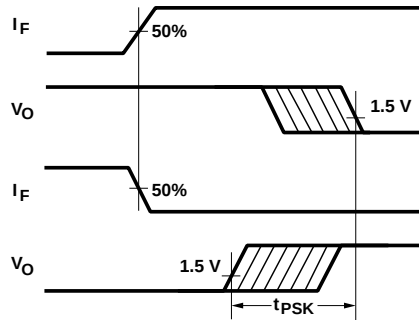


Figure 19. Illustration of Propagation Delay Skew - t_{PSK} .

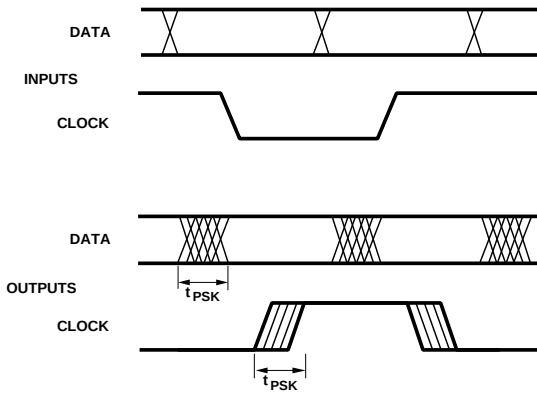


Figure 20. Parallel Data Transmission Example.

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